

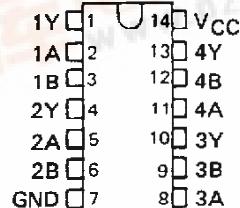
SN5433, SN54LS33, SN7433, SN74LS33 QUADRUPLE 2-INPUT POSITIVE-NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS

SDLS101

DECEMBER 1983—REVISED MARCH 1988

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

SN5433, SN54LS33 . . . J OR W PACKAGE
SN7433 . . . N PACKAGE
SN74LS33 . . . D OR N PACKAGE
(TOP VIEW)



description

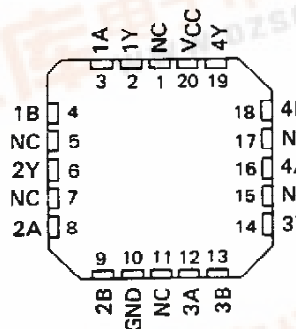
These devices contain four independent 2-input NOR buffer gates with open-collector outputs. Open-collector outputs require resistive pull-up to perform logically but can deliver higher V_{OH} levels and are commonly used in wired-AND applications.

The SN5433 and SN54LS33 are characterized for operation over the full military temperature range of -55°C to 125°C . The SN7433, and SN74LS33 are characterized for operation from 0°C to 70°C .

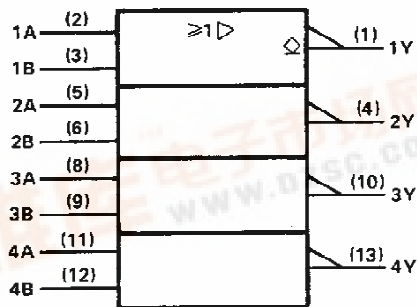
FUNCTION TABLE (each gate)

INPUTS		OUTPUT
A	B	Y
H	X	L
X	H	L
L	L	H

SN54LS33 . . . FK PACKAGE
(TOP VIEW)

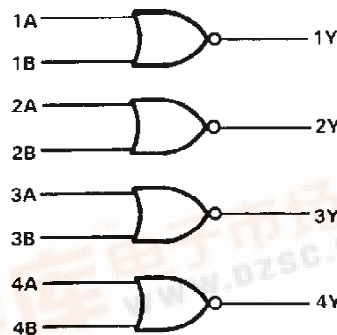


logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for D, J, N, and W packages.

logic diagram

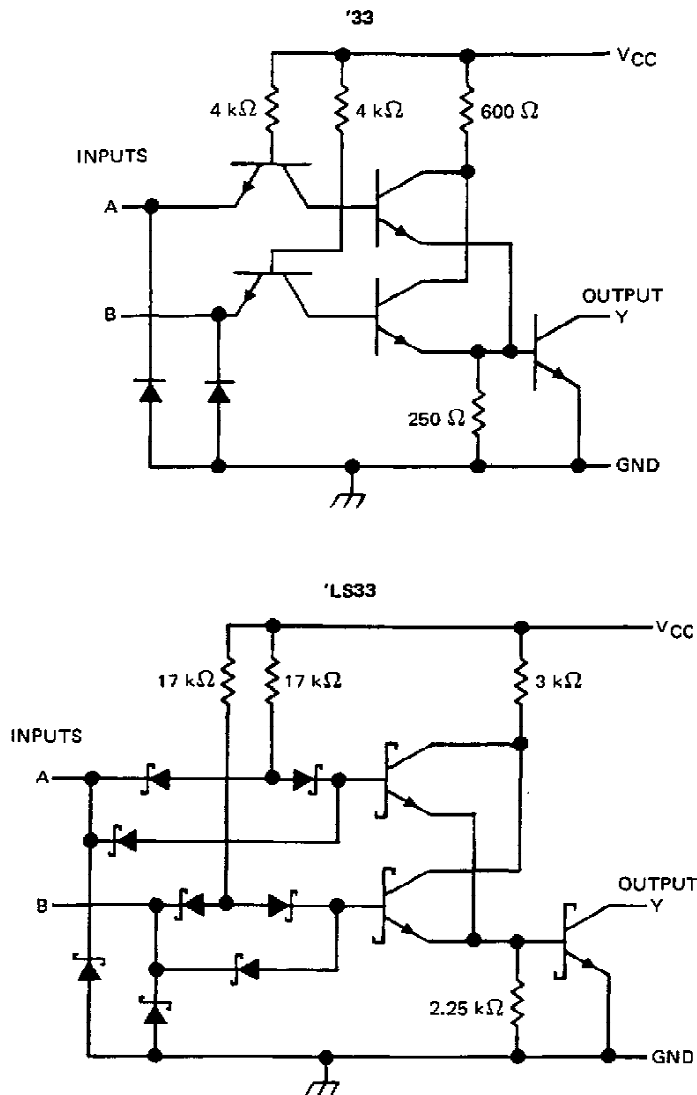


positive logic

$$Y = A + B \text{ or } Y = \bar{A} \cdot \bar{B}$$

SN5433, SN54LS33, SN7433, SN74LS33 **QUADRUPL 2-INPUT POSITIVE-NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS**

schematics (each gate)



Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage: '33	5.5 V
'LS33	7 V
Off-state output voltage	7 V
Operating free-air temperature: SN54'	-55°C to 125°C
SN74'	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

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SN5433, SN7433

QUADRUPLE 2-INPUT POSITIVE-NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS

recommended operating conditions

		SN5433			SN7433			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V _{IH}	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
V _{OH}	High-level output voltage			5.5			5.5	V
I _{OL}	Low-level output current			48			48	mA
T _A	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	SN5433		SN7433		UNIT
		MIN	TYP‡ MAX	MIN	TYP‡ MAX	
V _{IK}	V _{CC} = MIN, I _I = -12 mA	-1.5		-1.5		V
I _{OH}	V _{CC} = MIN, V _{IL} = 0.8 V, V _{OH} = 5.5 V			0.25		mA
	V _{CC} = MIN, V _{IL} = 0.7 V, V _{OH} = 5.5 V	0.25				
V _{OL}	V _{CC} = MIN, V _{IH} = 2 V, I _{OL} = 16 mA	0.2	0.4	0.2	0.4	V
I _I	V _{CC} = MAX, V _I = 5.5 V	1		1		mA
I _{IH}	V _{CC} = MAX, V _I = 2.4 V	40		40		μA
I _{IL}	V _{CC} = MAX, V _I = 0.4 V	-1.6		-1.6		mA
I _{CCH}	V _{CC} = MAX, V _I = 0	3	6	3	6	mA
I _{CCL}	V _{CC} = MAX, See Note 2	9	16.5	9	16.5	mA

†For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡All typical values are at V_{CC} = 5 V, T_A = 25°C.

NOTE 2: One input at 4.5 V, all others at 0 V.

switching characteristics, V_{CC} = 5 V, T_A = 25°C (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH}	A or B	Y	R _L = 133 kΩ, C _L = 50 pF		10	15	ns
t _{PHL}					12	18	ns
t _{PLH}			R _L = 133 kΩ, C _L = 150 pF		15	22	ns
t _{PHL}					16	24	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

SN54LS33, SN74LS33 **QUADRUPLE 2-INPUT POSITIVE-NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS**

recommended operating conditions

	SN54LS33			SN74LS33			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC} Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V_{IH} High-level input voltage	2			2			V
V_{IL} Low-level input voltage			0.7			0.8	V
V_{OH} High-level output voltage			5.5			5.5	V
I_{OL} Low-level output current			12			24	mA
T_A Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS †	SN54LS33			SN74LS33			UNIT
		MIN	TYP ‡	MAX	MIN	TYP ‡	MAX	
V_{IK}	$V_{CC} = \text{MIN.}$, $I_I = -18 \text{ mA}$		-1.5			-1.5		V
I_{OH}	$V_{CC} = \text{MIN.}$, $V_{IH} = 2 \text{ V.}$, $V_{IL} = \text{MAX.}$, $V_{OH} = 5.5 \text{ V}$		0.25			0.25		mA
V_{OL}	$V_{CC} = \text{MIN.}$, $V_{IH} = 2 \text{ V.}$, $V_{IL} = \text{MAX.}$, $I_{OL} = 12 \text{ mA}$	0.25	0.4		0.25	0.4		V
	$V_{CC} = \text{MIN.}$, $V_{IL} = \text{MAX.}$, $I_{OL} = 24 \text{ mA}$				0.35	0.5		
I_I	$V_{CC} = \text{MAX.}$, $V_I = 7 \text{ V}$		0.1			0.1		mA
I_{IH}	$V_{CC} = \text{MAX.}$, $V_I = 2.7 \text{ V}$		20			20		µA
I_{IL}	$V_{CC} = \text{MAX.}$, $V_I = 0.4 \text{ V}$		-0.4			-0.4		mA
I_{CCH}	$V_{CC} = \text{MAX.}$, $V_I = 0$	1.8	3.6		1.8	3.6		mA
I_{CCL}	$V_{CC} = \text{MAX.}$, See Note 2	6.9	13.8		6.9	13.8		mA

†For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

NOTE 2: One input at 4.5 V, all others at 0 V.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$ (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	A or B	Y	$R_L = 667 \Omega$, $C_L = 45 \text{ pF}$	20	32		ns
t_{PHL}				18	28		ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

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